Index of Claims 10575675 Examiner Leung, Quyen P Applicant(s)/Patent Under Reexamination KHRUSHCHEV ET AL. Art Unit 2874

✓	Rejected	-	Cancelled	N	Non-Elected	Α	Appeal
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	Application/Control No.	Applicant(s)/Patent Under Reexamination
Index of Claims	10575675	KHRUSHCHEV ET AL.
	Examiner	Art Unit
	Leung, Quyen P	2874

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